

# Excess Mechanical Loss From Dielectric Mirror Coatings on Interferometer Test Masses

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# Mirror substrate materials

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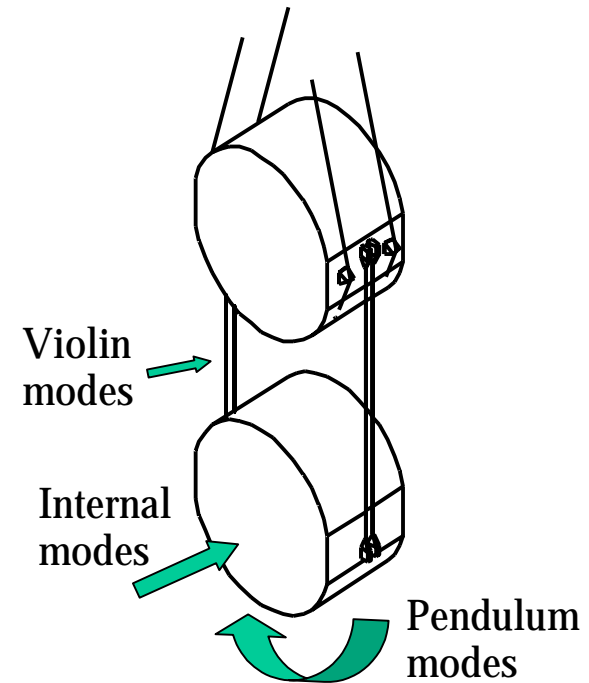
- From measurements of intrinsic loss factor (and other considerations – suitability for polishing etc) two most likely choices for advanced interferometer test masses
  - Sapphire
  - Fused silica
- Possible areas of excess loss are being addressed
  - Bonding silica to sapphire to allow suspension of test masses on silica fibers
  - Dielectric mirror coatings

# Reminders

## Consider thermal noise in g.w. interferometers

- Thermal motion of test masses well below their resonances sets sensitivity between few 10s and few 100 Hz - want loss factor of test mass materials as low as possible over this range
- Very difficult to measure directly - hence measure  $Q$  or  $\phi(\omega_0)$  at resonant frequencies - assume can deduce off resonance thermal noise from this

(n.b. This method requires care..)



Schematic final stage of mirror suspension

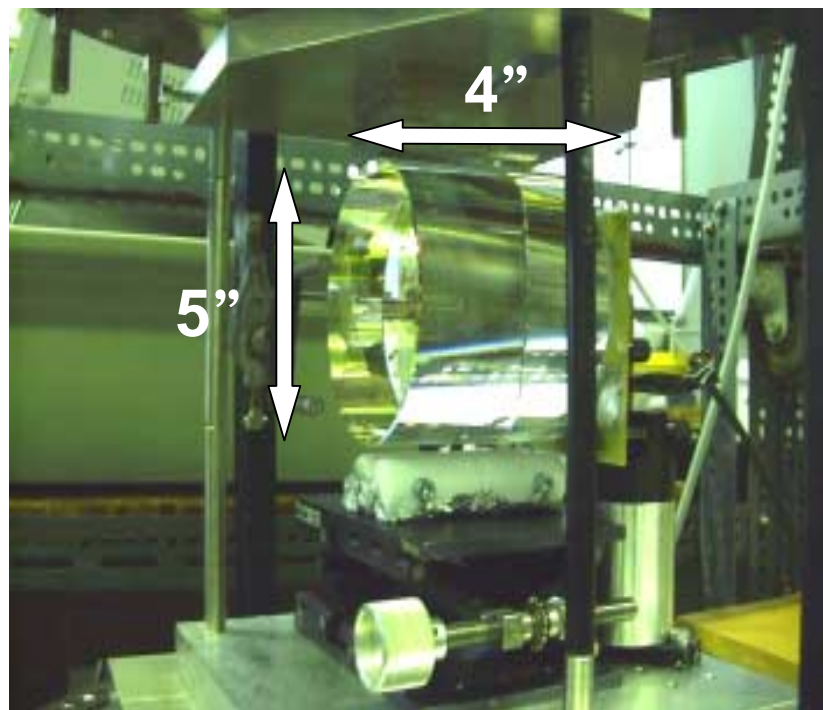
# Excess loss introduced by coatings

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- Aim
  - Measure  $Q$  (loss) of samples before and after application of a dielectric mirror coating to **estimate level of any excess mechanical loss associated with coating**
- Interpretation
  - how does this affect thermal noise in an interferometer

# Fused silica substrates

- Corning 7940 (3G)
- 2 samples (nominally identical\*)
- Dimensions 5 in. dia x 4 in. thick (size of mirrors in Glasgow 10m prototype)
- 1 sample uncoated
- 1 sample coated by **General Optics**
  - HR @1064nm
  - AR @ 1064nm
  
- Qs measured for 6 modes of each mass



**Test mass in Q measurement apparatus**

# Excess loss introduced by coatings

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- Ideally measure Q (loss,  $\phi(\omega_0)$ ) on coated and uncoated mass

$$\phi(\omega_0)_{\text{coated}} = \phi(\omega_0)_{\text{uncoated}} + \phi(\omega_0)_{\text{associated with coating}} \quad (1)$$

$$\phi(\omega_0)_{\text{coated}} = \phi(\omega_0)_{\text{uncoated}} + \frac{E_{\text{coating face}}}{E_{\text{bulk}}} \phi(\omega_0)_{\text{coating face}} + \frac{E_{\text{barrel coating}}}{E_{\text{bulk}}} \phi(\omega_0)_{\text{barrel coating}} \quad (2)$$

- use FE program to evaluate ratios of energy stored in coatings on barrel and faces to energy stored in bulk of samples (D. Crooks, G. Cagnoli)
- in principle allows values for the loss of the coating on the faces and on the barrel to be calculated

# Interpretation of results for coating loss

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- **Assume structural (frequency independent) damping for measured loss of coating material**
- (Compare magnitudes of calculated thermo-elastic loss for coating with Brownian thermal noise at frequency range of interest for GW detectors - show it is not significant)
- **Calculate effect on predicted performance of advanced LIGO detector using methods of Nakagawa et al**

# Results for silica sample

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Mode	Frequency (Hz)	Coated mass	Uncoated mass
Bending	22361	$1.6 \times 10^{-7}$	$0.95 \times 10^{-7}$
Asy. Dr.	23004	$1.2 \times 10^{-7}$	$1 \times 10^{-7}$
Fund	25404	$0.5 \times 10^{-7}$	$0.88 \times 10^{-7}$
Clover (4)	26193	$1.9 \times 10^{-7}$	$0.95 \times 10^{-7}$
Sym. dr.	28395	$3.6 \times 10^{-7}$	$0.95 \times 10^{-7}$
2 <sup>nd</sup> Asy. dr.	36072	$0.9 \times 10^{-7}$	$0.87 \times 10^{-7}$

**Note relatively constant loss for uncoated mass at a level significantly greater than best measurement of coated mass**



# Results for silica

- Thus cannot use uncoated mass as a reference.
- Suggests the **coated and uncoated substrates have different intrinsic losses** (perhaps due to damage from mechanical polish?) **\*\*Now known to be of different materials**
- Instead use results **only from coated mass** -

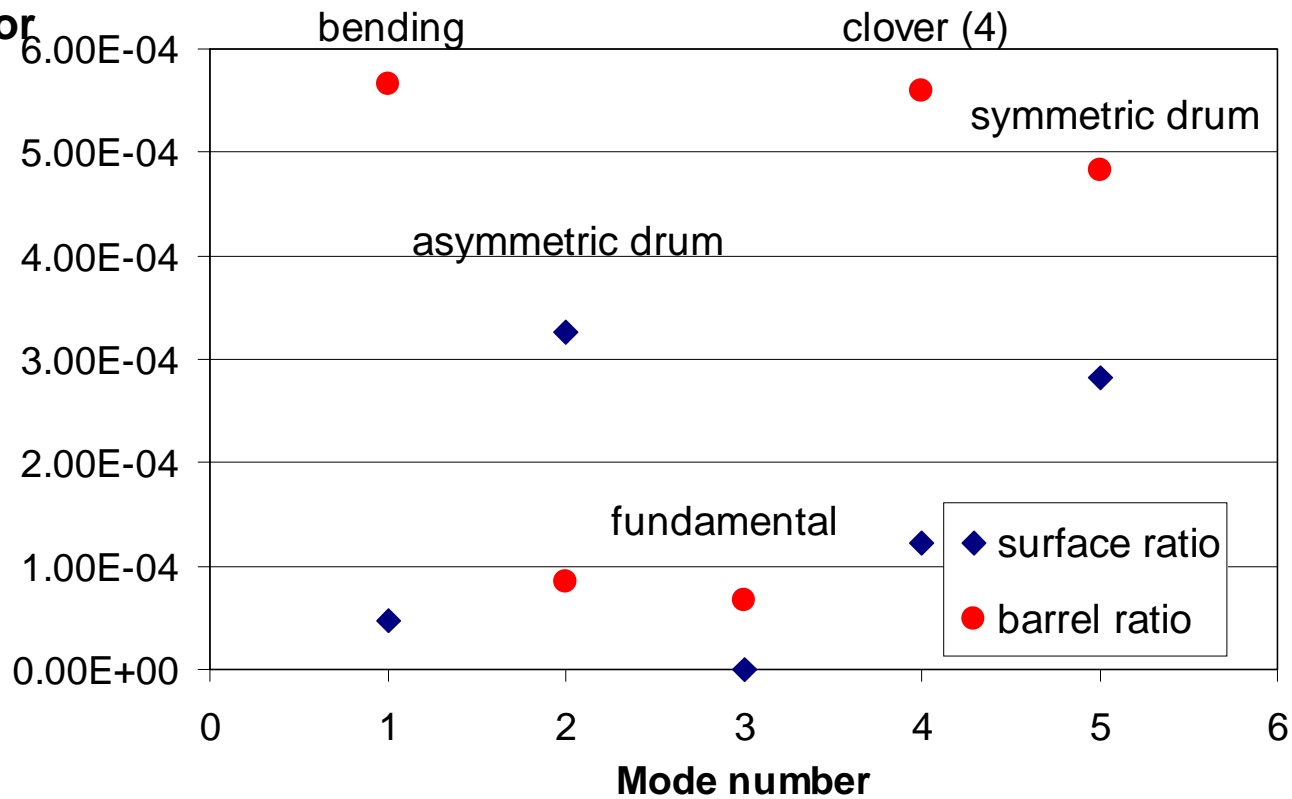
$$\phi_{\text{coated}} = \phi_{\text{bulk}} + \frac{Y_{\text{coating}}}{Y_{\text{bulk}}} \frac{E_{\text{surface}}}{E_{\text{bulk}}} \phi_{\text{coating face}} + \frac{E_{\text{barrel}}}{E_{\text{bulk}}} \phi_{\text{eff}}$$

Where  $\phi_{\text{eff}}$  absorbs variations in coating thickness and elastic modulus,  $Y$ , on the barrel

- Take five modes of coated mass, in groups of three, and use to solve above eqn for  $\phi_{\text{bulk}}$ ,  $\phi_{\text{coating}}$  and  $\phi_{\text{effective}}$
- 7 of the 10 combinations give relatively consistent results
- **nb suspension losses assumed negligible**

# Fraction of energy in a 10 micron thick surface layer of silica sample (assuming isotropic material properties)

Fraction of total energy stored in surface or barrel



# Silica coating losses

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Taking the averages of the 7 sets of results gives,  
for coated 7940 fused silica:

$\phi_{\text{intrinsic}}$	$\phi_{\text{coating}}$	$\phi_{\text{eff}}$ (barrel)
$(4.4 \pm 0.5) \times 10^{-8}$	$(1.7 \pm 0.3) \times 10^{-4}$	$(9 \pm 1) \times 10^{-5}$

Repeating this experiment on a sample of coated 7980  
fused silica:

$\phi_{\text{intrinsic}}$	$\phi_{\text{coating}}$	$\phi_{\text{eff}}$ (barrel)
$(5.8 \pm 0.3) \times 10^{-8}$	$(1.5 \pm 0.5) \times 10^{-4}$	$(1.4 \pm 0.2) \times 10^{-5}$

# Interpretation for advanced LIGO (1)

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- From Nakagawa et al (submitted to LSC for rev.) the spectral density of thermal noise from a coated mass is related to the spectral density of an uncoated mass by

$$S_{\phi}^{\text{total}}(f) = S_{\phi}^{\text{single}}(f, \phi_{\text{bulk}}) \left\{ 1 + \frac{2}{\sqrt{\pi}} \frac{(1-2\sigma)}{(1-\sigma)} \frac{\phi_{\text{coating}}}{\phi_{\text{bulk}}} \left( \frac{d}{w} \right) \right\}$$

**Excess factor**

- where  $\sigma$  is the Poisson ratio of the bulk material,  $d$  is the coating thickness and  $w$  is the beam spot radius
- The above formula holds for the assumption that the coating and substrate have the same mechanical properties (Young's modulus and Poisson ratio)

# Interpretation for advanced LIGO (2)

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- Modifying this “excess factor” for the case where the coating and substrate materials have differing Young’s moduli and Poisson’s ratio gives:

(N. Nakagawa , Private communication)

- Excess factor =

$$\left\{ 1 + \frac{1}{\sqrt{\pi}} \frac{(1 + \sigma_{\text{coating}})}{(1 - \sigma_{\text{bulk}}^2)(1 - \sigma_{\text{coating}})} \frac{\phi_{\text{coating}} Y_{\text{bulk}}}{\phi_{\text{bulk}} Y_{\text{coating}}} \left[ (1 - 2\sigma_{\text{coating}}) + (1 - 2\sigma_{\text{bulk}})^2 \frac{(1 + \sigma_{\text{bulk}})^2}{(1 + \sigma_{\text{coating}})^2} \left( \frac{Y_{\text{coating}}}{Y_{\text{bulk}}} \right)^2 \right] \left( \frac{d}{w} \right) \right\}$$

# Evaluation of excess noise due to coating

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- Let:

$$d = 10\mu\text{m} \text{ and } w = 6 \times 10^{-2}\text{m}$$

$$\phi_{\text{bulk}} = 3.3 \times 10^{-8} \text{ for fused silica}$$

$$Y_{\text{bulk}} = 7.2 \times 10^{10} \text{ Pa}$$

$$\sigma_{\text{bulk}} = 0.17$$

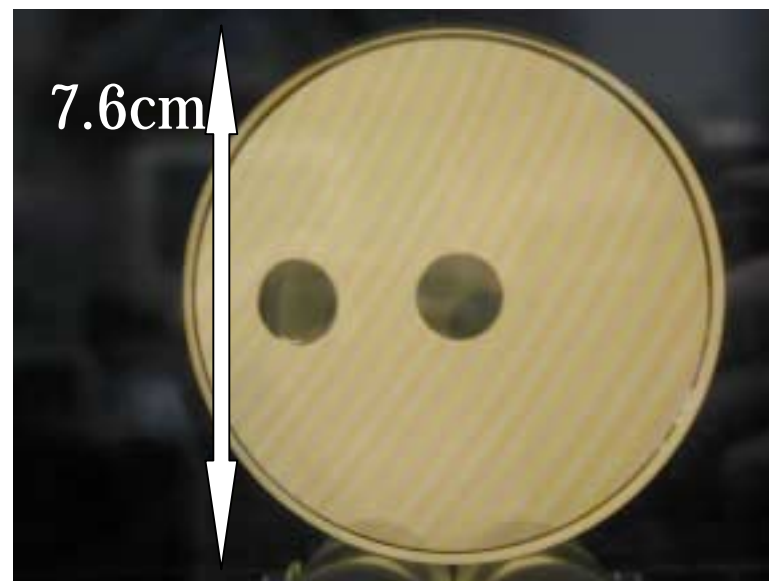
$$Y_{\text{coating}} = 10.5 \times 10^{10} \text{ (taking average of } Y\text{'s for SiO}_2 \text{ and Ta}_2\text{O}_5\text{)}$$

$$\sigma_{\text{coating}} = 0.21 \text{ (taking average of } \sigma\text{'s SiO}_2 \text{ and Ta}_2\text{O}_5\text{)}$$

- Our measurements give  $\phi_{\text{coating}} \sim 1.7 \times 10^{-4}$
- Suggests power spectral density of noise is increased by  $1 + 0.62 = \text{X}1.62$
- **so amplitude spectral density of noise increased by X1.27**

# Sapphire substrate

- Crystal Systems
- m-axis sample
- Dimensions 7.6cm dia x 3cm thick
- Q's of 5 modes measured with sample uncoated
- Sample then coated by REO
  - HR @1064nm
  - AR @ 1064nm
- Q's re-measured for each mode
- **nb: Complication - coatings have run over on to large portion of barrel surface**



View of m-axis sapphire sample, on loan from LIGO project, through crossed polarizers. Dark spots are small amounts of Al, used as mirrors

# Results for sapphire sample

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Mode	Frequency (Hz)		Loss before coating	Loss after coating
	measured	modelled		
'Clover (4) leaf'	35674	35085	$3.5 \times 10^{-8}$	$9.4 \times 10^{-8}$
Asymmetric drum	54850	53074	$4.5 \times 10^{-8}$	$15 \times 10^{-8}$
Bending	68633	66657	$11 \times 10^{-8}$	$14 \times 10^{-8}$
Fundamental	82980	82296	$1.9 \times 10^{-8}$	$6.4 \times 10^{-8}$
'Clover (6) leaf'	87267	88292	$3.7 \times 10^{-8}$	$9.4 \times 10^{-8}$

Note: loss before coating is different for different modes - suggests suspension losses non-zero - possibly due to visibly poor barrel polish.



# Calculation of coating loss

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- From previously:

$$\phi_{\text{after coating}} = \phi_{\text{before coating}} + \frac{E_{\text{coating face}}}{E_{\text{bulk}}} \phi_{\text{coating face}} + \frac{E_{\text{barrel coating}}}{E_{\text{bulk}}} \phi_{\text{barrel coating}}$$

Becomes:

$$\phi_{\text{after coating}} = \phi_{\text{before coating}} + \frac{Y_{\text{coating}}}{Y_{\text{bulk}}} \frac{E_{\text{surface}}}{E_{\text{bulk}}} \phi_{\text{coating face}} + \frac{E_{\text{barrel}}}{E_{\text{bulk}}} \phi_{\text{eff}}$$

- Apply to the modes in pairs and solve for  $\phi_{\text{coating}}$  and  $\phi_{\text{eff}}$

# Coating losses

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- This time, of the 10 mode pair combinations, results for  $\phi$  of the coating were very scattered - possibly due to variable suspension losses?
- So, concentrate on the two simplest modes - the fundamental and the asymmetric drum
- These give:

$$\phi_{\text{coating}} = 3.7 \times 10^{-4} \text{ and } \phi_{\text{effl}} = 1.5 \times 10^{-4}$$

# Interpretation for advanced LIGO

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- Evaluation of excess noise due to coating
- Consider  $f = 250\text{Hz}$ , close to maximum interferometer sensitivity
- $\phi_{\text{bulk}}$  (due to thermo-elastic damping)  $\sim 3 \times 10^{-8}$

Let:

$$Y_{\text{bulk}} = 3.6 \times 10^{11} \text{Pa}$$

$$\sigma_{\text{bulk}} = 0.23$$

-Then excess factor =  $1 + 3.16 = 4.16$

-ie noise power is increased by  $\times 4.2$  at 250Hz

-so amplitude spectral density increased by  $\times 2.04$

# Conclusions

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- Experiments suggest coating losses are of a level which may be significant for advanced LIGO
- Coating losses in sapphire seem greater in sapphire than silica - substrate effect or supplier effect?
- Topics to be addressed:
  - What is source of loss - homogenous throughout layers of coating; coating/substrate interface; interface between individual layer.....
  - Does loss differ for coatings from different vendors
  - Is loss observed greater for sapphire substrates